

# INTERNATIONAL STANDARD

# NORME INTERNATIONALE

BASIC EMC PUBLICATION

PUBLICATION FONDAMENTALE EN CEM

**Electromagnetic compatibility (EMC) –  
Part 4-15: Testing and measurement techniques – Flickermeter – Functional  
and design specifications**

**Compatibilité électromagnétique (CEM) –  
Partie 4-15: Techniques d'essai et de mesure – Flickermètre – Spécifications  
fonctionnelles et de conception**



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## INTERNATIONAL ELECTROTECHNICAL COMMISSION

**ELECTROMAGNETIC COMPATIBILITY (EMC) –****Part 4-15: Testing and measurement techniques –  
Flickermeter – Functional and design specifications**

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International Standard IEC 61000-4-15 has been prepared by subcommittee 77A: Low frequency phenomena, of IEC technical committee 77: Electromagnetic compatibility.

IEC 61000-4-15 is based on work by the “Disturbances” Working Group of the International Union for Electroheat (UIE), on work of the IEEE, and on work within IEC itself.

It forms part 4-15 of the IEC 61000 series. It has the status of a basic EMC publication in accordance with IEC Guide 107.

This second edition cancels and replaces the first edition published in 1997 and its Amendment 1 (2003) and constitutes a technical revision. This new edition, in particular, adds or clarifies the definition of several directly measured parameters, so that diverging interpretations are avoided.

The text of this standard is based on the following documents:

FDIS	Report on voting
77A/722/FDIS	77A/730/RVD

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts of the IEC 61000 series, under the general title *Electromagnetic compatibility (EMC)* can be found on the IEC website.

The committee has decided that the contents of this publication will remain unchanged until the stability date indicated on the IEC web site under "<http://webstore.iec.ch>" in the data related to the specific publication. At this date, the publication will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

## INTRODUCTION

IEC 61000-4 is a part of the IEC 61000 series, according to the following structure:

- Part 1: General
  - General consideration (introduction, fundamental principles)
  - Definitions, terminology
- Part 2: Environment
  - Description of the environment
  - Classification of the environment
  - Compatibility levels
- Part 3: Limits
  - Emission limits
  - Immunity limits (in so far as they do not fall under the responsibility of the product committees)
- Part 4: Testing and measurement techniques
  - Measurement techniques
  - Testing techniques
- Part 5: Installation and mitigation guidelines
  - Installation guidelines
  - Mitigation methods and devices
- Part 6: Generic standards
- Part 9: Miscellaneous

Each part is further subdivided into several parts, published either as international standards, as technical specifications or technical reports, some of which have already been published as sections. Others are and will be published with the part number followed by a dash and completed by a second number identifying the subdivision (example: IEC 61000-6-1).

## **ELECTROMAGNETIC COMPATIBILITY (EMC) –**

### **Part 4-15: Testing and measurement techniques – Flickermeter – Functional and design specifications**

#### **1 Scope and object**

This part of IEC 61000 gives a functional and design specification for flicker measuring apparatus intended to indicate the correct flicker perception level for all practical voltage fluctuation waveforms. Information is presented to enable such an instrument to be constructed. A method is given for the evaluation of flicker severity on the basis of the output of flickermeters complying with this standard.

The flickermeter specifications in this part of IEC 61000 relate only to measurements of 120 V and 230 V, 50 Hz and 60 Hz inputs. Characteristics of some incandescent lamps for other voltages are sufficiently similar to the values in Table 1 and Table 2, that the use of a correction factor can be applied for those other voltages. Some of these correction factors are provided in the Annex B. Detailed specifications for voltages and frequencies other than those given above, remain under consideration.

The object of this part of IEC 61000 is to provide basic information for the design and the instrumentation of an analogue or digital flicker measuring apparatus. It does not give tolerance limit values of flicker severity.

#### **2 Normative references**

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60068 (all parts), *Environmental testing*

IEC 61000-3-3, *Electromagnetic compatibility (EMC) – Part 3-3: Limits – Limitation of voltage changes, voltage fluctuations and flicker in public low-voltage supply systems, for equipment with rated current  $\leq 16$  A per phase and not subject to conditional connection*

IEC 61000-3-11, *Electromagnetic compatibility (EMC) – Part 3-11: Limits – Limitation of voltage changes, voltage fluctuations and flicker in public low-voltage supply systems – Equipment with rated current  $\leq 75$  A and subject to conditional connection*

IEC 61010-1, *Safety requirements for electrical equipment for measurement, control, and laboratory use – Part 1: General requirements*

IEC 61326-1, *Electrical equipment for measurement, control and laboratory use – EMC requirements – Part 1: General requirements*